

60A 650V Trench Fieldstop IGBT with anti-parallel diode SRE60N065FSU2DH
General Description

The SRE60N065FSU2DH is a Field Stop Trench IGBT with anti-parallel diode, which offers ultra-low switching losses, high energy efficiency for switching applications such as PFC, Power Supply, Inverter, etc.

The SRE60N065FSU2DH package is TO-247.

Features

- High Breakdown Voltage to 715V@ $T_j=25^{\circ}\text{C}$
- Advanced Trench Fieldstop technology
 - Ultra low E_{off}
 - High Ruggedness, Temperature Stability
 - Easy Parallel Switching Capability due to Positive Temperature Coefficient in $V_{CE(SAT)}$
- Low $V_{CE(SAT)}$
- Enhanced Avalanche Capability
- Non-Automotive Qualified

Application

- Inverter
- Uninterruptible power supplies
- PFC application
- Converter with high switching frequency

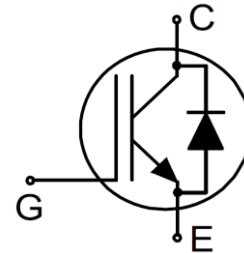
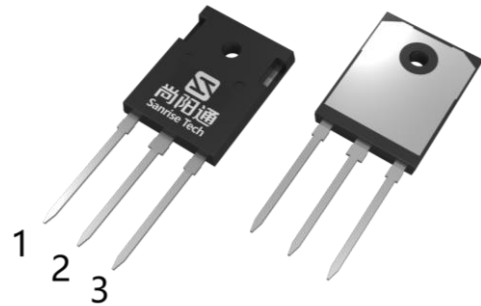
Symbol


Figure 1 Symbol of SRE60N065FSU2DH

Package Type


TO-247

- Pin 1- gate
- Pin 2&backside-collector
- Pin 3-emitter

Figure 2 Package Type of SRE60N065FSU2DH

Ordering Information

SRE60N065FSU2DH □ □ - □

Circuit Type			
Package			
T: TO-247			

G: Green
 Blank: Tube
 TR: Tape & Reel

Package	Part Number	Marking ID	Packing Type
TO-247	SRE60N065FSU2DHT-G1	SRE60N065FSU2DHTG1	Tube

60A 650V Trench Fieldstop IGBT with anti-parallel diode SRE60N065FSU2DH
Absolute Maximum Ratings

Parameter		Symbol	Rating	Unit
Collector-emitter Voltage		V_{CES}	650	V
Gate-emitter Voltage		V_{GES}	± 20	V
Transient Gate-emitter Voltage			± 30	V
Continuous Collector Current	$T_C=25^\circ\text{C}$	I_C	100	A
	$T_C=100^\circ\text{C}$		60	
Pulsed Collector Current, Limited by T_{Jmax}		I_{CM}	240	A
Diode Continuous Collector Current	$T_C=25^\circ\text{C}$	I_F	80	A
	$T_C=100^\circ\text{C}$		60	
Diode Pulsed Current, Limited by T_{Jmax}		I_{FM}	200	A
Power Dissipation	$T_C=25^\circ\text{C}$	P_{tot}	306	W
	$T_C=100^\circ\text{C}$		153	
Operating Junction Temperature Range		T_J	-40 ~ 175	$^\circ\text{C}$
Storage Temperature Range		T_{STG}	-55 ~ 150	$^\circ\text{C}$
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	$^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
IGBT Thermal Resistance, Junction-to-Case	R_{thJC}	-	-	0.49	$^\circ\text{C/W}$
Diode Thermal Resistance, Junction-to-Case	R_{thJC}	-	-	0.62	
Thermal Resistance, Junction-to-Ambient	R_{thJA}	-	-	40	

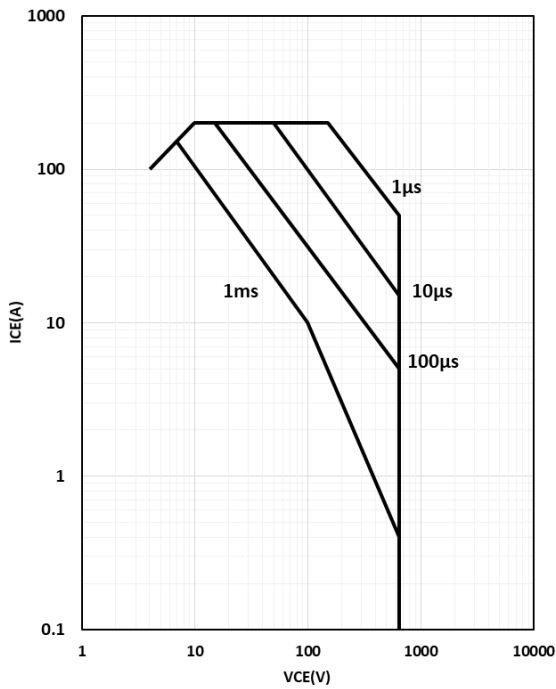
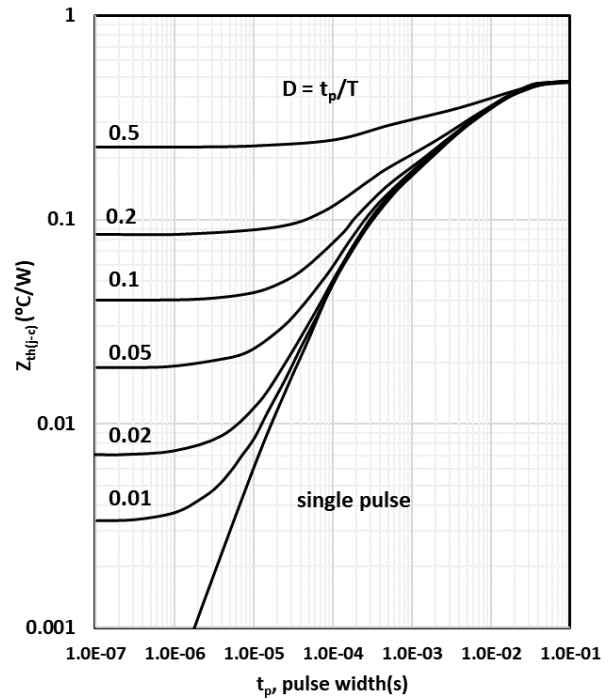
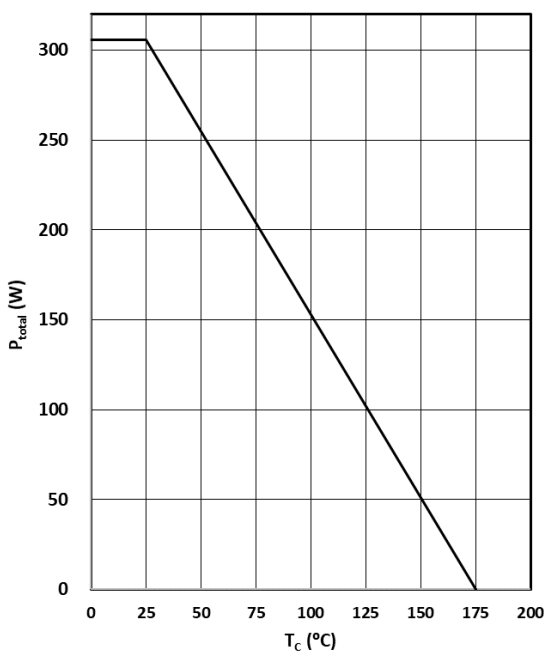
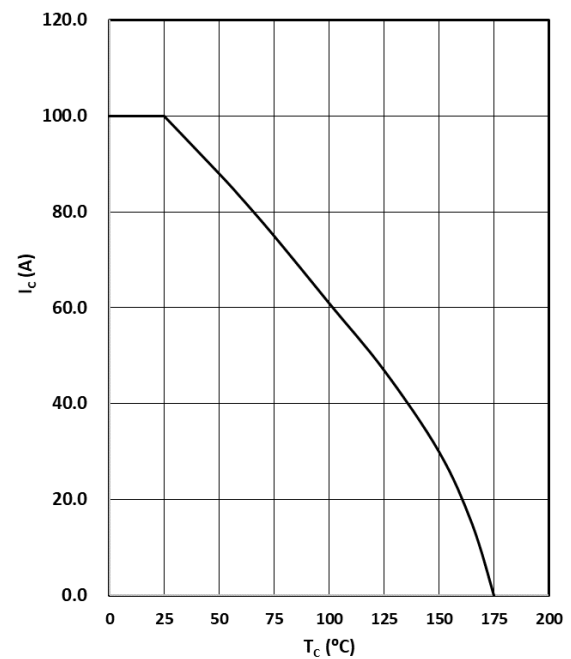
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Electrical Characteristics

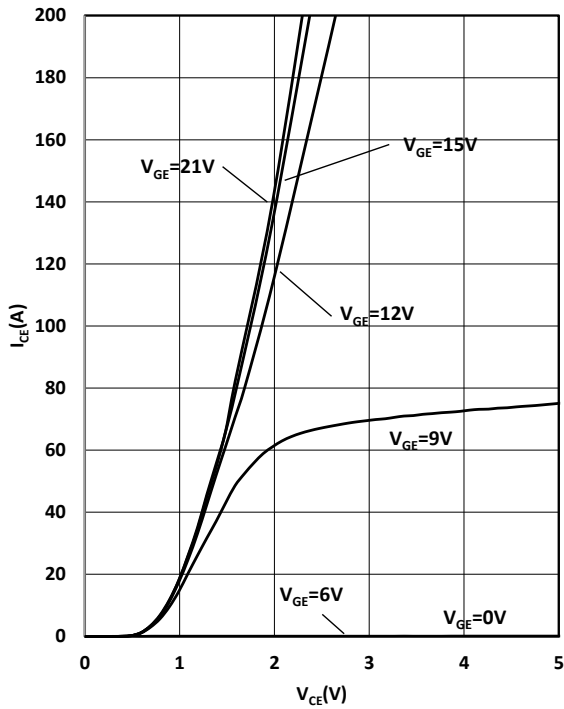
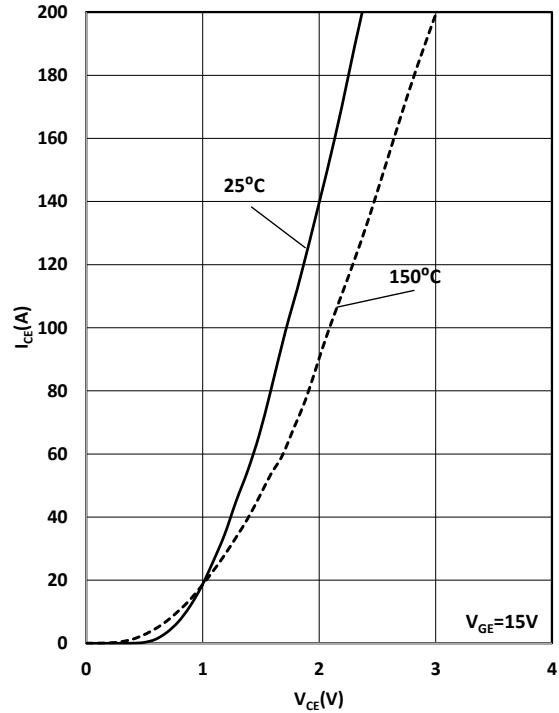
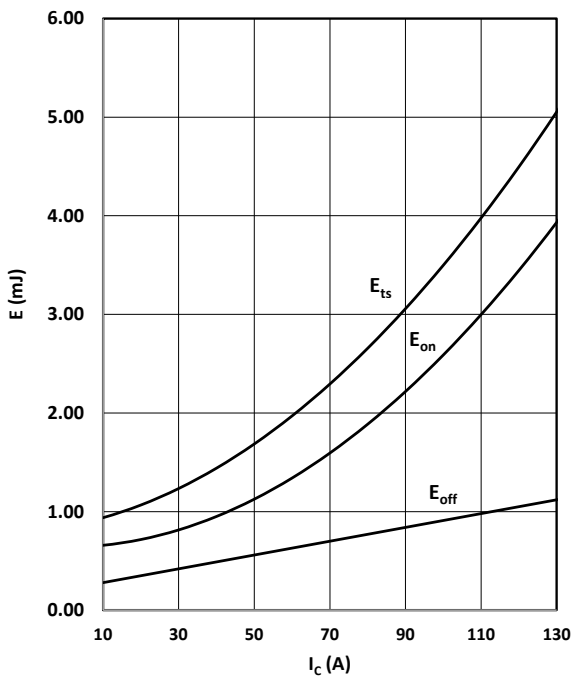
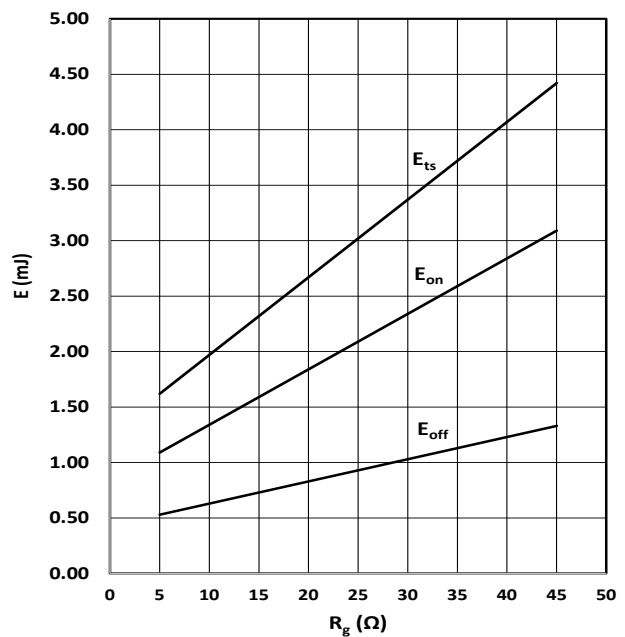
 T_J = 25°C, unless otherwise specified.

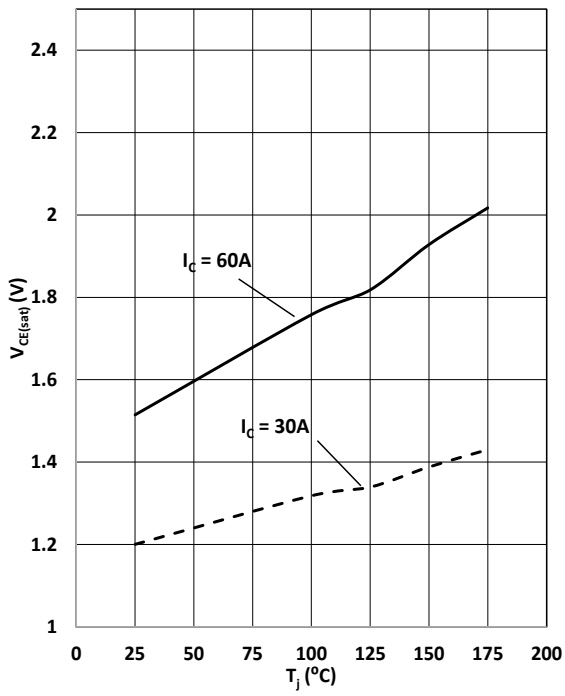
Parameter		Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Statistic Characteristics								
Collector-emitter Voltage	Breakdown	BV _{CES}	V _{GE} =0V, I _C =1mA	715			V	
Gate Threshold Voltage		V _{GE(th)}	V _{CE} =V _{GE} , I _C =250μA	4.0	4.8	5.6	V	
Collector-emitter saturation voltage		V _{CEsat}	V _{GE} =15V, I _C =60A, T _J =25°C		1.51	1.80	V	
			T _J =125°C		1.81		V	
			T _J =175°C		2.05		V	
Zero Gate Voltage Collector Current		I _{CES}	V _{CE} =650V, V _{GE} =0V T _J =25°C		0.1	40	μA	
			T _J =175°C			1	mA	
Gate-emitter Current	Leakage Forward	I _{GESF}	V _{GE} =20V, V _{CE} =0V			100	nA	
	Reverse	I _{GESR}	V _{GE} =-20V, V _{CE} =0V			-100	nA	
Dynamic Characteristics								
Input Capacitance		C _{IES}	V _{CE} =25V, V _{GE} =0V, f=100KHz		2460		pF	
Output Capacitance		C _{OES}			247			
Reverse Transfer Capacitance		C _{RES}			48			
Gate Resistance		R _G	f=1 MHz, Open Drain		1.53		Ω	
Turn-on Delay Time		t _{d(on)}	T _J =25°C V _{CC} =400V, I _C =60A R _G =10Ω, V _{GE} =0/15V Energy losses include "tail" and diode reverse recovery		21		ns	
Rise Time		t _r			38		ns	
Turn-off Delay Time		t _{d(off)}			122		ns	
Fall Time		t _f			70		ns	
Turn-on energy		E _{on}			1.34		mJ	
Turn-off energy		E _{off}			0.63		mJ	
Total switching energy		E _{ts}			1.97		mJ	
Turn-on Delay Time		t _{d(on)}		T _J =150°C V _{CC} =400V, I _C =60A R _G =10Ω, V _{GE} =0/15V Energy losses include "tail" and diode reverse recovery		18		ns
Rise Time		t _r				39		ns
Turn-off Delay Time		t _{d(off)}				149		ns
Fall Time		t _f			118		ns	
Turn-on energy		E _{on}			2.43		mJ	
Turn-off energy		E _{off}			0.92		mJ	
Total switching energy		E _{ts}			3.35		mJ	
Gate to Emitter Charge		Q _{GE}	V _{CC} =400V, I _C =60A V _{GE} =0 to 15V			28		nC
Gate to Collector Charge		Q _{GC}			91			
Gate Charge Total		Q _G			190			

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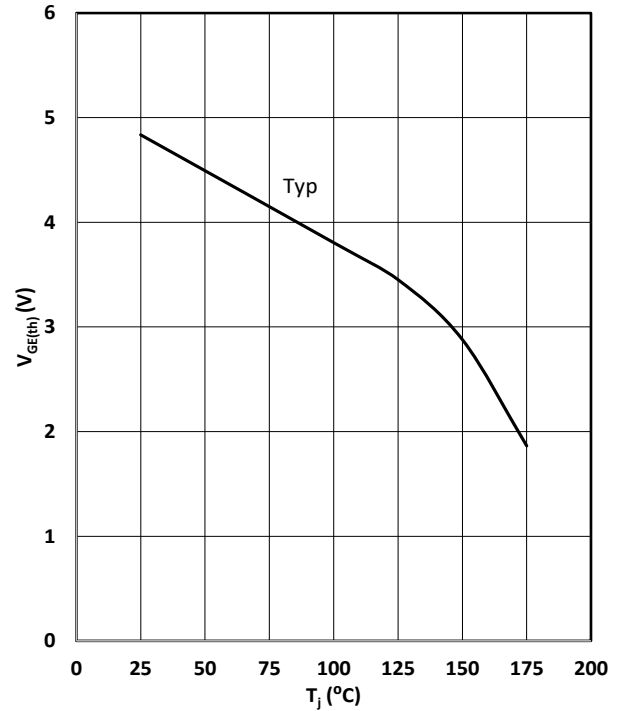
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Reverse Diode Characteristics						
Diode Forward Voltage	V_F	$I_F=30A$ $T_J=25^\circ C$		1.41	1.95	V
		$I_F=30A$ $T_J=125^\circ C$		1.23		
		$I_F=30A$ $T_J=175^\circ C$		1.12		
		$I_F=60A$ $T_J=25^\circ C$		1.62	2.15	
		$I_F=60A$ $T_J=125^\circ C$		1.52		
		$I_F=60A$ $T_J=175^\circ C$		1.36		
Reverse Recovery Time	t_{rr}	$T_J=25^\circ C$ $V_R=400V, I_F=30A$ $dI_F/dt=1000A/\mu s$		90		ns
Reverse Recovery Charge	Q_{rr}			0.88		uC
Peak Reverse Recovery Current	I_{rrm}			21		A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt			-530		A/ μs
Reverse Recovery Time	t_{rr}	$T_J=25^\circ C$ $V_R=400V, I_F=60A$ $dI_F/dt=1000A/\mu s$		100		ns
Reverse Recovery Charge	Q_{rr}			1.1		uC
Peak Reverse Recovery Current	I_{rrm}			20.4		A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt			-470		A/ μs

Typical Performance Characteristics
Figure 3: IGBT FBSOA

 $I_C = f(V_{CE}); V_{GE} \geq 15/0V; T_j \leq 175^\circ C$
Figure 4: IGBT transient thermal impedance

 $R_{th(j-c)} = f(t_p); \text{ duty cycle: } D = t_p/T$
Figure 5: Power dissipation

 $P_{tot} = f(T_c);$
Figure 6: Collector current vs. temperature

 $I_c = f(T_j); V_{GE} \geq 15V; T_j \leq 175^\circ C$

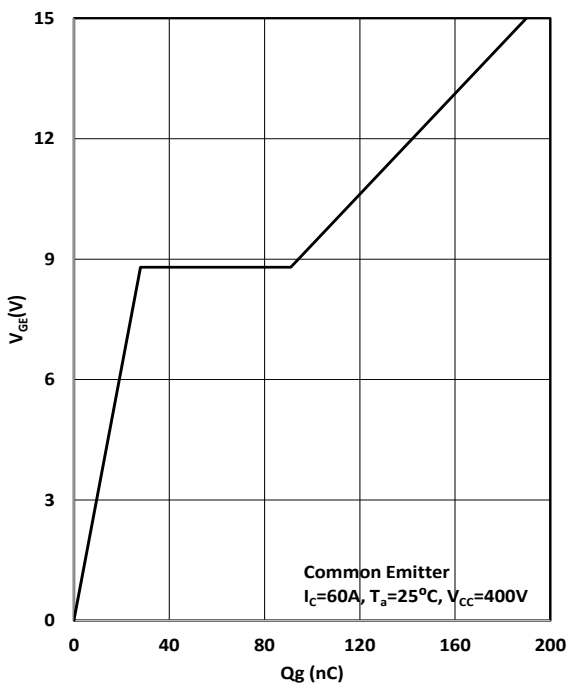
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Figure 7: Typical Output Characteristics

 $I_C = f(V_{CE}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GE}$
Figure 8: Typical transfer characteristic

 $I_C = f(V_{CE}); T_j = 25^\circ\text{C vs } 150^\circ\text{C}$
Figure 9: Typical switching energy losses as a function of collector current

 $E = f(I_C); V_{CE} = 400\text{V}; T_j = 25^\circ\text{C}; R_G = 10\Omega$
Figure 10: Typical switching energy losses as a function of gate resistor

 $E = f(R_G); V_{CE} = 400\text{V}; T_j = 25^\circ\text{C}; I_C = 60\text{A}$

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Figure 11: Typical collector-emitter saturation voltage as a function of junction temperature


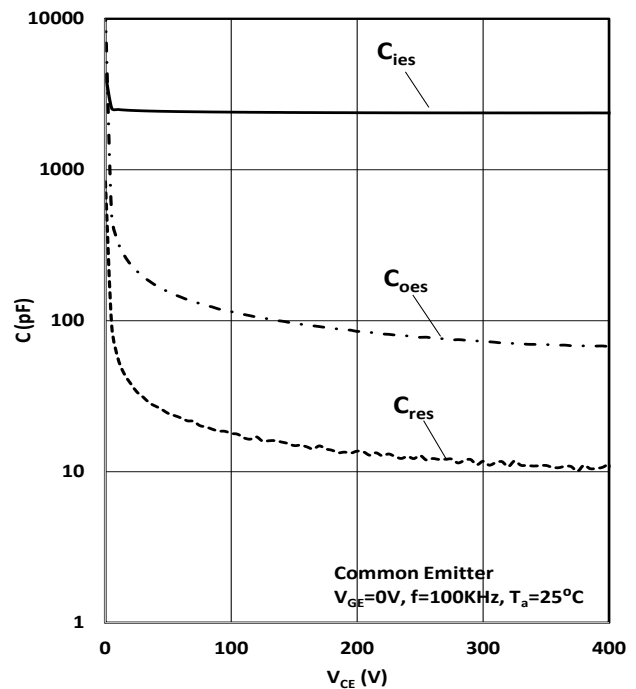
$$V_{CE} = f(T_j); V_{GE} = 15V$$

Figure 12: Gate-emitter threshold voltage as a function of junction temperature


$$V_{GE} = f(T_j); I_{CE} = 250\mu A$$

Figure 13: Typical Gate Charge


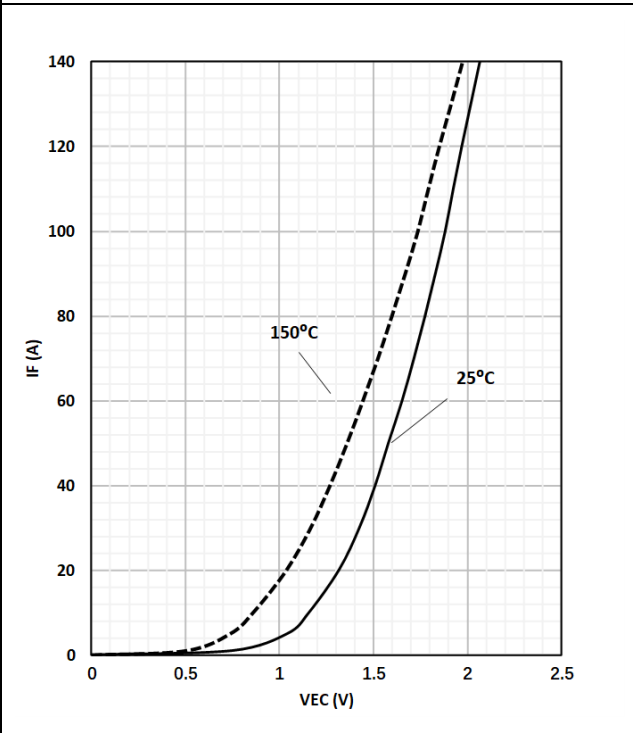
$$V_{GE} = f(Q_{gate}); I_C = 60A$$

Figure 14: Typical Capacitances


$$C = f(V_{CE}); V_{GE} = 0; f = 100KHz$$

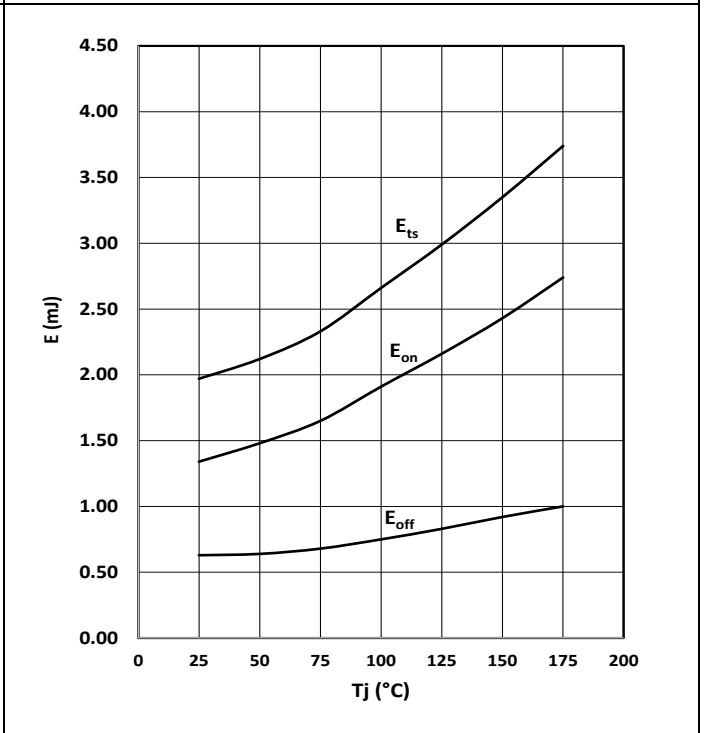
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Figure 15: Typical diode forward current as a function of forward voltage



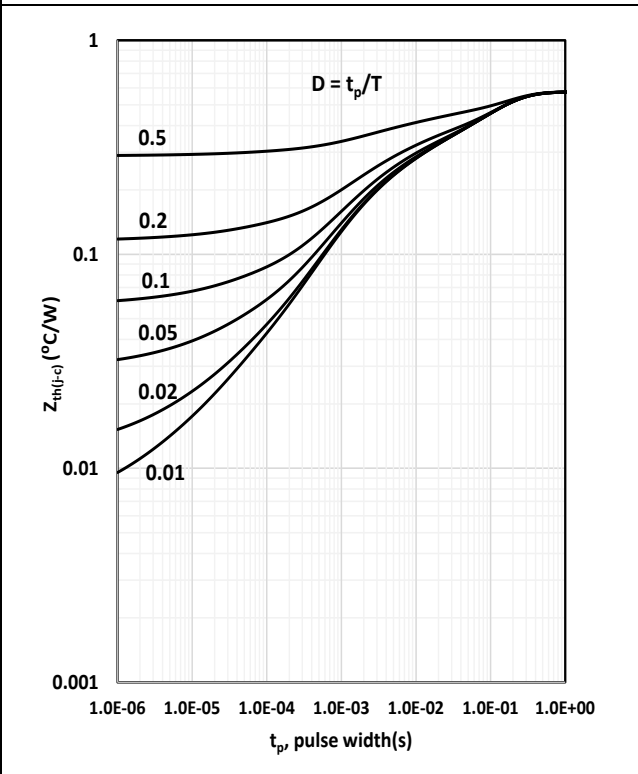
$$I_F = f(V_{EC});$$

Figure 16: Typical switching energy losses as a function of junction temperature

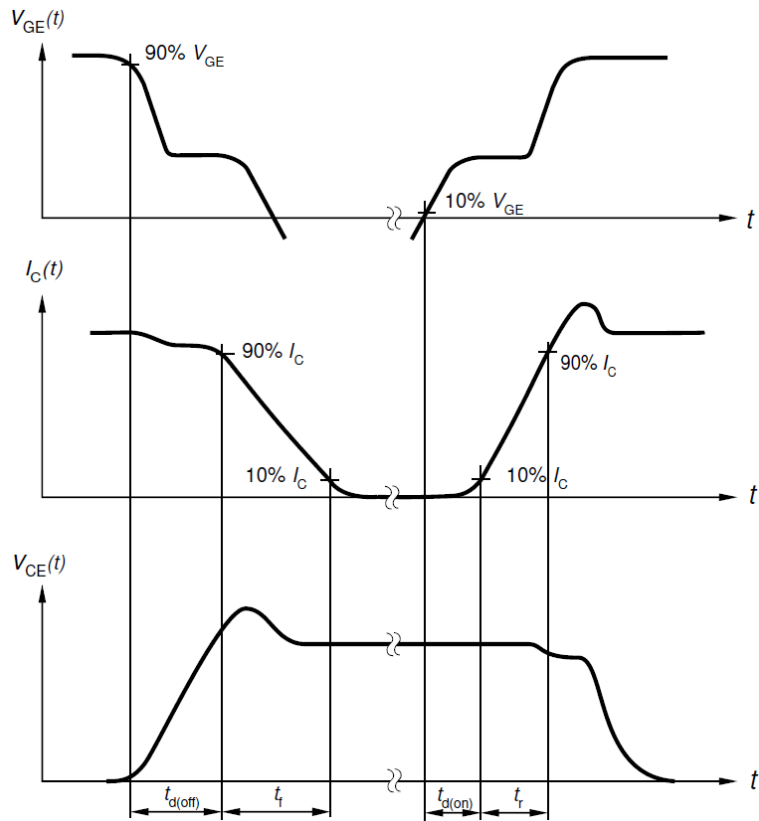
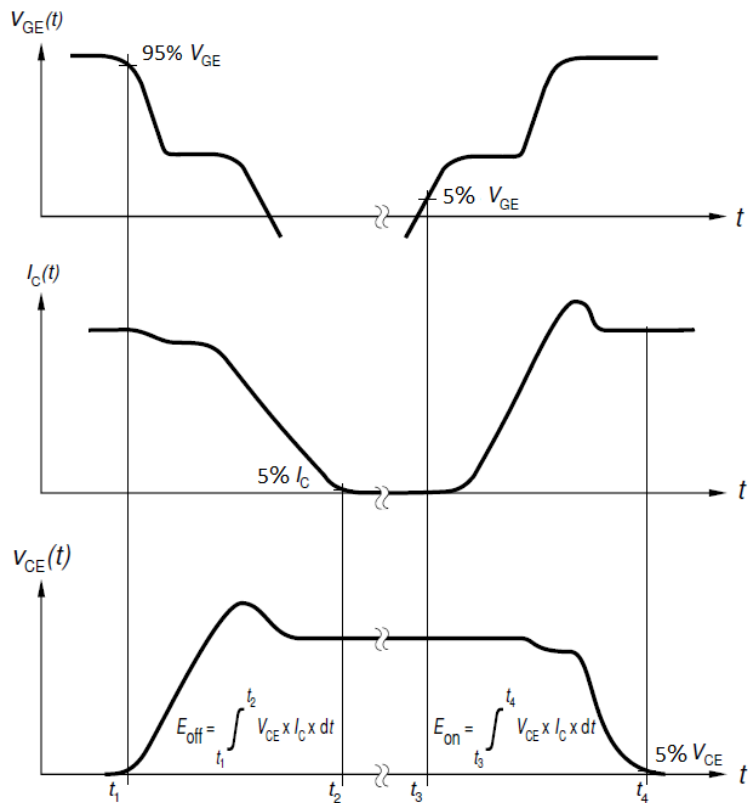


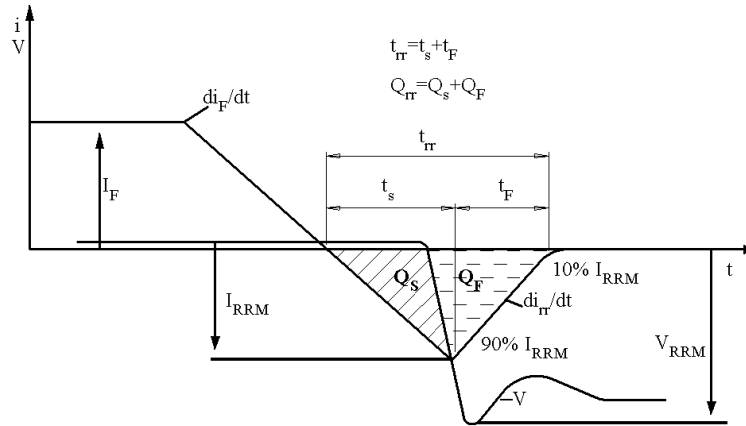
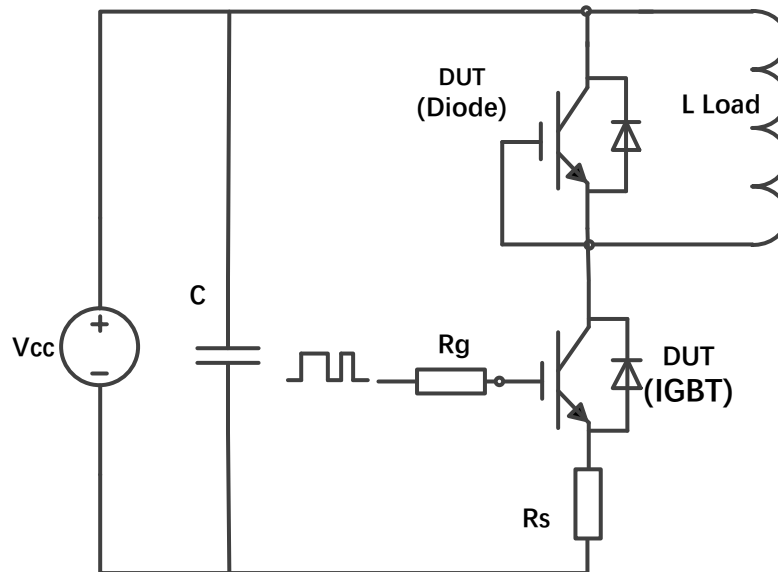
$$E = f(T_j); V_{CE} = 400V; I_c = 60A; R_G = 10\Omega$$

Figure 17: FRD transient thermal impedance



$$R_{th(j-c)} = f(t_p); \text{ duty cycle: } D = t_p/T$$

Test Circuits
1. Definition Switching times

2. Definition Switching losses


3. Definition Diode Switching Characteristics

4. Dynamic test circuit


60A 650V Trench Fieldstop IGBT with anti-parallel diode SRE60N065FSU2DH

Symbol [↵]	Dimensions (mm) [↵]			Symbol [↵]	Dimensions (mm) [↵]		
	Min. [↵]	Typ. [↵]	Max. [↵]		Min. [↵]	Typ. [↵]	Max. [↵]
A [↵]	4.80 [↵]	5.00 [↵]	5.20 [↵]	E2 [↵]	- [↵]	5.00 [↵]	- [↵]
A1 [↵]	2.21 [↵]	2.41 [↵]	2.61 [↵]	E3 [↵]	- [↵]	2.50 [↵]	- [↵]
A2 [↵]	1.90 [↵]	2.00 [↵]	2.10 [↵]	e [↵]	- [↵]	5.44 [↵]	- [↵]
b [↵]	1.10 [↵]	1.20 [↵]	1.35 [↵]	L [↵]	19.42 [↵]	19.92 [↵]	20.42 [↵]
b1 [↵]	- [↵]	2.00 [↵]	- [↵]	L1 [↵]	- [↵]	4.13 [↵]	- [↵]
b2 [↵]	- [↵]	3.00 [↵]	- [↵]	P [↵]	3.50 [↵]	3.60 [↵]	3.70 [↵]
c [↵]	0.55 [↵]	0.60 [↵]	0.75 [↵]	P1 [↵]	- [↵]	7.19 [↵]	- [↵]
D [↵]	20.80 [↵]	21.00 [↵]	21.20 [↵]	P2 [↵]	- [↵]	2.50 [↵]	- [↵]
D1 [↵]	- [↵]	16.55 [↵]	- [↵]	Q [↵]	- [↵]	5.80 [↵]	- [↵]
D2 [↵]	- [↵]	1.20 [↵]	- [↵]	S [↵]	6.05 [↵]	6.15 [↵]	6.25 [↵]
E [↵]	15.60 [↵]	15.80 [↵]	16.00 [↵]	T [↵]	- [↵]	10.00 [↵]	- [↵]
E1 [↵]	- [↵]	13.30 [↵]	- [↵]	U [↵]	- [↵]	6.20 [↵]	- [↵]



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Main Site:

- Headquarter

Shenzhen Sanrise Technology Co., LTD.
A1206, Skyworth building, No. 008, gaoxinnan 1st Road,
Gaoxin District, Yuehai street, Nanshan District, ShenZhen,
P.R. China

Tel: +86-755-22953335

Fax: +86-755-22916878

- Shanghai Office

Shenzhen Sanrise Technology Co., LTD.
Rm.401, Building B, No. 666, Zhangheng Road,
Zhangjiang Hi-Tech Park, Shanghai, P.R.China

Tel: +86-21-68825918